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IM9110

SMD TEST FIXTURE

Instruction Manual

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Introduction

Thank you for purchasing the Hioki IM9110 SMD Test Fixture. To obtain maximum performance from the device, please read this manual first, and keep it handy for future reference.

Verifying Package Contents

When you receive the device, inspect it carefully to ensure that no damage occurred during shipping. In particular, check the connectors. If damage is evident, or if it fails to operate according to the specifications, contact your authorized Hioki distributor or reseller.

Please remove the seal which holds the control lever before using the device for the first time.

Precautions during shipment

- Store the packaging in which the device was delivered, as you will need it when transporting the device.
- To avoid damage to the device, use the original packing materials in which it was shipped, and be sure to pack in a double carton. Damage occurring during transportation is not covered by the warranty.
- When sending the device for repair, be sure to include a description of the problem.

Repair

If you are unable to make measurement even after cleaning the measurement location with the supplied cleaning brush, contact your authorized Hioki distributor or reseller.

Consumable parts

The short compensation jig is a consumable part and can be purchased. If it is lost or if it is unable to perform compensation due to deformation, please contact your authorized Hioki distributor or reseller.

Disposal

Handle and dispose of the device in accordance with local regulations.

Safety Notes

Before using the device, be certain to carefully read the following safety notes:

CAUTION

- · Mishandling during use could damage to the device. Be certain that you understand the instructions and precautions in the manual before use.
- · If persons unfamiliar with electricity measuring device are to use the device, another person familiar with such devices must supervise operations.

Notations

In this manual, the risk seriousness and the hazard levels are classified as follows.



Indicates a potentially hazardous situation that may result in death or serious injury to the



Indicates a potentially hazardous situation that may result in minor or moderate injury to the operator or damage to the device or malfunction.



Indicates prohibited actions.



Indicates the action which must be performed.

Symbols for standards



Indicates that the product conforms to regulations set out by the EC Directive.



Indicates the Waste Electrical and Electronic Equipment Directive (WEEE Directive) in EU member states.

Operating Precautions

Follow these precautions to ensure safe operation and to obtain the full benefits of the various functions.



/ WARNING

Installing the device in inappropriate locations may cause a malfunction of device or may give rise to an accident. Avoid the following locations:

- · Exposed to direct sunlight or high temperature
- Exposed to corrosive or combustible gases
- · Exposed to a strong electromagnetic field or electrostatic charge



- Near induction heating systems (such as highfrequency induction heating systems and IH cooking equipment)
- Susceptible to vibration
- Exposed to water, oil, chemicals, or solvents
- Exposed to high humidity or condensation
- · Exposed to high quantities of dust particles
- · Do not use the device beyond its rated and specification ranges. Doing so may damage the device or cause it to become hot, resulting in electric shock.
- · Customers are not allowed to modify, disassemble, or repair the device. Doing so may cause fire, electric shock, or injury.
 - To avoid electric shock when using the IM9110 with the 9268 or 9268-10 DC Bias Voltage Unit, never touch the measurement terminals while a DC voltage (DC vias) is being input.

/ CAUTION

To avoid damage to the device, protect it from physical shock when transporting and handling. Be especially careful to avoid physical shock from dropping.

Overview

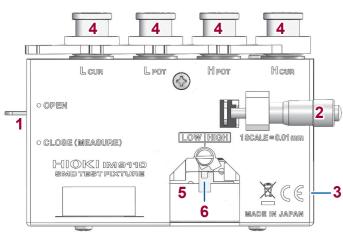
The IM9110 SMD Test Fixture is a test fixture for SMD components that connects directly to the measurement terminal (UNKNOWN terminal) on a Hioki LCR meter or Hioki C meter. It allows you to perform measurement of 0201 chip size component (L/W/T = $0.25 \text{ mm} \times 0.125 \text{ mm} \times 0.125 \text{ mm}$) with side contact. Since this device comes equipped with a micrometer, the distance between two measurement probes can be easily set.

Specifications

Connectable instruments	Auto balancing bridge type Hioki LCR meters or Hioki C meters		
Supported models	3506-10, 3511-50, 3522-50, 3532-50, IM3523, IM3533, IM3533-01, IM3536, IM3570, IM3590 (as of August, 2018) For updated information, contact your authorized Hioki distributor or reseller.		
Operating environment	Indoors, altitude up to 2000 m (6562 ft.)		
Operating temperature and humidity	0°C to 40°C (32°F to 104°F), 80% RH or less (no condensation)		
Storage temperature and humidity	-10°C to 55°C (14°F to 131°F), 80% RH or less (no condensation)		
Dimensions	Approx. 99W × 42H × 73D mm /3.90"W × 1.65"H × 2.87"D (Exclusing protruding parts such as the control lever, lock lever, and micrometer)		
Mass	Approx. 270 g (9.5 oz.)		
Product warranty period	3 years This warranty does not apply to measurement probes, holder (at the measurement location), and movable parts.		
Connection to measuring instrument	4-terminal pair design		
Instrument connectors	BNC (connector spacing: 22 mm)		
Contact with DUT (sample)	Side contact, 2-terminal design		
Measurable DUT (sample) size	0.25 ±20% × 0.125 ±10% × 0.125 ±10% mm (JIS: 0201)		
Maximum input voltage	±42 V peak (AC+DC)		
Maximum input current	0.15 A rms (±0.15 A DC)		
Usable frequency range	DC to 1 MHz		
Residual parameter values (reference values at 1 MHz measurement frequency)	Capacitance: C < 35 fF (when the distance between two measurement probes is set to 0.25 mm) Inductance: L < 120 nH (2-terminal design using a short compensation jig) Resistance: R < 800 m Ω (2-terminal design using a short compensation jig) The L and R values stated are when the contact pressure is 0.1 N (10.2 gf) (with 0.1 mm push)		
Contact pressure applied to DUT (sample)	0.14 N (14.3 gf) or less 0.09 N (9.2 gf) + 0.01 N (1 gf) /0.1 mm (The value varies with the micrometer's setting.)		
Distance setting between two measurement probes	With a 0.01 mm increment micrometer		
Accessories	 Instruction manual × 1 Short compensation jig × 5 (packed in a translucent container) Cleaning brush × 1 		

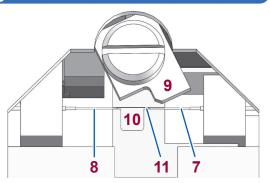
www.valuetronics.com

Part Names



1	Control lever
2	Micrometer (The smallest increment of the scale = 0.01 mm, one full turn = 0.5 mm)
3	Enclosure
4	BNC connectors (with lock levers) for signal connections
5	Measurement location
6	Holder

Enlarged view of the measurement location

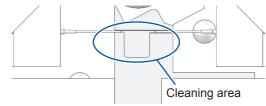


	7	Measurement probe (fixed side)	10	Temporary placing table
	8	Measurement probe (movable side)	11	Guide groove
	9	Open and close cover (linked with the control lever)		

Cleaning

Measurement location

Clean the measurement location regularly with the cleaning brush provided with the instrument. Move the control lever to the **OPEN** position and gently move the brush back and forth several times.



Other areas of the device

To clean the device, wipe it gently with a soft cloth moistened with water or mild detergent.

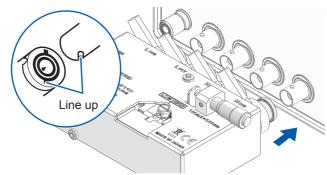
Connecting to the Instrument

Inspection Before Use

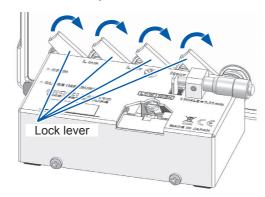
Before using the device, verify that it operates normally to ensure that no damage occurred during storage or shipping. If you find any damage, contact your authorized Hioki distributor or reseller.

CAUTION

- To prevent damage to the BNC connector, be sure to release the locking mechanism, grip the head of the connector, and pull it out.
- 1 Align the device's BNC connectors with the instrument's BNC connectors and insert them.



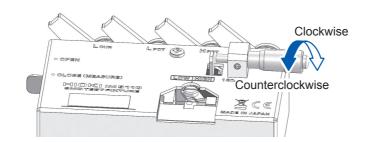
2 Lock the device in place with the lock lever.



Operating Micrometer

When the control lever is in the **CLOSE** (**MEASURE**) position, the distance between the two measurement probes can be set using the micrometer. Connect the device to the instrument first and then, by turning the micrometer's knob, find the position where the circuit state between the two measurement probes is switched between an open-circuit state (non-conducting state) and a short-circuit state (conducting state).

Turning the knob in clockwise direction	The distance between the two probes will become larger
Turning the knob in counterclockwise direction	The distance between the two probes will become smaller



Performing Short and Open Compensations

To reduce measurement error, perform compensations in the following order: short compensation and open compensation. The compensation method varies with the instrument to which the device is to be connected. See the manual that came with the instrument. It is necessary that the short compensation value is less than the resistance value specified in the "Residual parameter values" of the specifications. Have the device repaired if the short compensation value is particularly large even if the measurement location is cleaned regularly. (See "Cleaning" about how to clean the device.)

Short Compensation

You will need: A short compensation jig

- 1 Move the control lever to the OPEN position.
- Place the short compensation jig.
 (For the detailed procedure, see Steps 3 & 4 of "Performing Measurement".)
- 3 Move the control lever to the CLOSE (MEASURE) position.
- Turn the micrometer's knob until you find the position where the circuit state between the two measurement probes is switched between an open and a short state.
- Turn the micrometer's knob ten increments (0.1 mm) counterclockwise from that position and perform short compensation.
- 6 After short compensation is complete, move the control lever to the OPEN position and remove the short compensation jig by reversing the steps used to secure it in place.

To perform short compensation without using a short compensation jig (when it is lost or broken) (If the short compensation jig is not used, measured values may vary significantly due to the effects of contact resistance.)

- 1 Move the control lever to the CLOSE (MEASURE) position.
- Turn the micrometer's knob until you find the position where the circuit state between the two measurement probes is switched between an open and a short state.
- 3 Turn the micrometer's knob ten increments (0.1 mm) counterclockwise from that position and perform short compensation.

Open Compensation

To perform open compensation without using a DUT

- Move the control lever to the CLOSE (MEASURE)
- Turn the micrometer's knob until you find the position where the circuit state between the two measurement probes is switched between an open and a short state.
- 3 Turn the micrometer's knob one-half turn (0.25 mm) clockwise from that position and perform open compensation.

To perform open compensation using a DUT

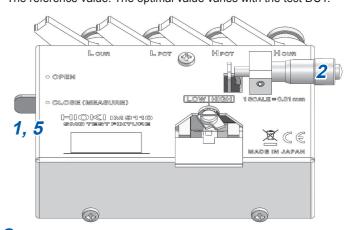
- Move the control lever to the OPEN position.
- Place the DUT.
- (For the detailed procedure, see Steps 3 & 4 of "Performing Measurement".)
- Move the control lever to the CLOSE (MEASURE) position.
- Turn the micrometer's knob until you find the position right before the mesurement probes come into contact with the DUT.
- Move the control lever to the OPEN position and remove the DUT.
- Move the control lever to the CLOSE (MEASURE) position and perform open compensation.

Performing Measurment

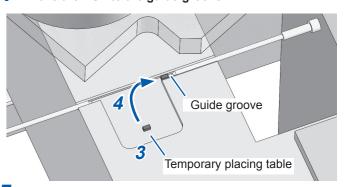
You will need: A pair of tweezers

- 1 Move the control lever to the OPEN position.
- Turn the micrometer's knob ten increments (0.1 mm)* counterclockwise from the position where the open compensation was performed.

*The reference value. The optimal value varies with the test DUT.



- Place the DUT on the temporary placing table using a pair of tweezers.
- **4** Move the DUT to the guide groove.



- 5 Move the control lever to the CLOSE (MEASURE) position.
- Perform measurement with the instrument.
- After measurement is complete, move the control lever to the OPEN position and remove the DUT by reversing the steps used to secure it in place.

To make a continuous measurement, repeat Steps 3 through 7.